Cool MOS™ Power Transistor

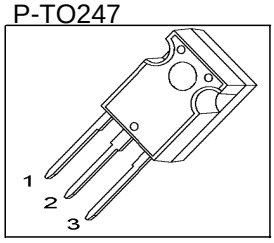
Feature

- New revolutionary high voltage technology
- Worldwide best $R_{DS(on)}$ in TO 247
- Ultra low gate charge
- Periodic avalanche rated
- Extreme d*v*/d*t* rated
- Ultra low effective capacitances
- Improved noise immunity

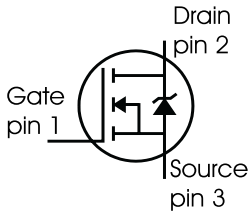
Product Summary

V_{DS}	600	V
$R_{DS(on)}$	0.07	Ω
I_D	47	A

P-TO247



Type	Package	Ordering Code	Marking
SPW47N60C2	P-TO247	Q67040-S4323	47N60C2



Maximum Ratings, at T_C = 25°C, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	I_D		A
T_C = 25 °C		47	
T_C = 100 °C		30	
Pulsed drain current, t_p limited by T_{jmax}	$I_{D\ puls}$	94	
Avalanche energy, single pulse	E_{AS}	1800	mJ
I_D=10A, V_{DD}=50V			
Avalanche energy, repetitive t_{AR} limited by T_{jmax} [1)]	E_{AR}	1	
I_D=20A, V_{DD}=50V			
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I_{AR}	20	A
Reverse diode d*v*/d*t*	d*v*/d*t*	6	V/ns
I_S=47A, $V_{DS} < V_{DD}$, d*i*/d*t*=100A/µs, T_{jmax}=150°C			
Gate source voltage	V_{GS}	±20	V
Power dissipation, T_C = 25°C	P_{tot}	415	W
Operating and storage temperature	T_j , T_{stg}	-55... +150	°C

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R_{thJC}	-	-	0.3	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	62	
Linear derating factor		-	-	3.33	W/K
Soldering temperature, 1.6 mm (0.063 in.) from case for 10s	T_{sold}	-	-	260	°C

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Static Characteristics					
Drain-source breakdown voltage V_{GS}=0V, I_D=0.25mA	$V_{(BR)DSS}$	600	-	-	V
Drain-source avalanche breakdown voltage V_{GS}=0V, I_D=20A	$V_{(BR)DS}$	-	700	-	
Gate threshold voltage, V_{GS} = V_{DS} I_D=2.7mA	$V_{GS(th)}$	3.5	4.5	5.5	
Zero gate voltage drain current	I_{DSS}				µA
V_{DS} = 600 V, V_{GS} = 0 V, T_j = 25 °C		-	0.5	25	
V_{DS} = 600 V, V_{GS} = 0 V, T_j = 150 °C		-	-	250	
Gate-source leakage current V_{GS}=20V, V_{DS}=0V	I_{GSS}	-	-	100	nA
Drain-source on-state resistance V_{GS}=10V, I_D=30A, T_j=25°C	$R_{DS(on)}$	-	0.06	0.07	Ω
Gate input resistance f = 1 MHz, open drain	R_G	-	0.62	-	

[1]Repetitve avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

Electrical Characteristics , at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Characteristics						
Transconductance	g_{fs}	$V_{DS}\geq 2*I_D*R_{DS(on)max}$, I_D=30A	-	30	-	S
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=25V, f=1MHz	-	8800	-	pF
Output capacitance	C_{oss}		-	3150	-	
Reverse transfer capacitance	C_{rss}		-	36	-	
Effective output capacitance, [1] energy related	$C_{o(er)}$	V_{GS}=0V, V_{DS}=0V to 480V	-	233	-	pF
Effective output capacitance, [2] time related	$C_{o(tr)}$		-	470	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=380V, V_{GS}=0/13V, I_D=47A, R_G=1.8Ω, T_j=125°C	-	28	-	ns
Rise time	t_r		-	9.5	-	
Turn-off delay time	$t_{d(off)}$		-	103	155	
Fall time	t_f		-	9.6	14.4	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=350V, I_D=47A	-	56	-	nC
Gate to drain charge	Q_{gd}		-	123	-	
Gate charge total	Q_g	V_{DD}=350V, I_D=47A, V_{GS}=0 to 10V	-	220	286	
Gate plateau voltage	$V_{(plateau)}$	V_{DD}=350V, I_D=47A	-	8	-	V

[1] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

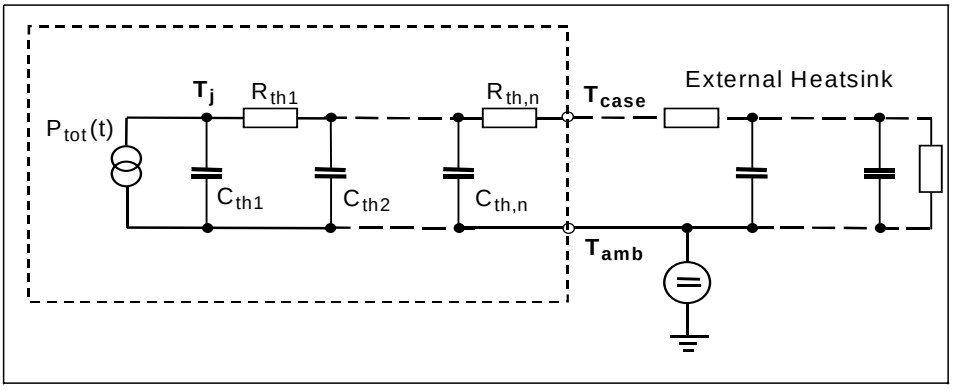
[2] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Characteristics						
Inverse diode continuous forward current	I_S	T_C=25°C	-	-	47	A
Inverse diode direct current, pulsed	I_{SM}		-	-	94	
Inverse diode forward voltage	V_{SD}	V_{GS}=0V, I_F=I_S	-	1	1.2	V
Reverse recovery time	t_{rr}	V_R=350V, I_F=I_S, di_F/dt=100A/µs	-	650	1100	ns
Reverse recovery charge	Q_{rr}		-	24	-	µC
Peak reverse recovery current	I_{rrm}		-	62	-	A
Peak rate of fall of reverse recovery current	di_{rr}/dt		-	2500	-	A/µs

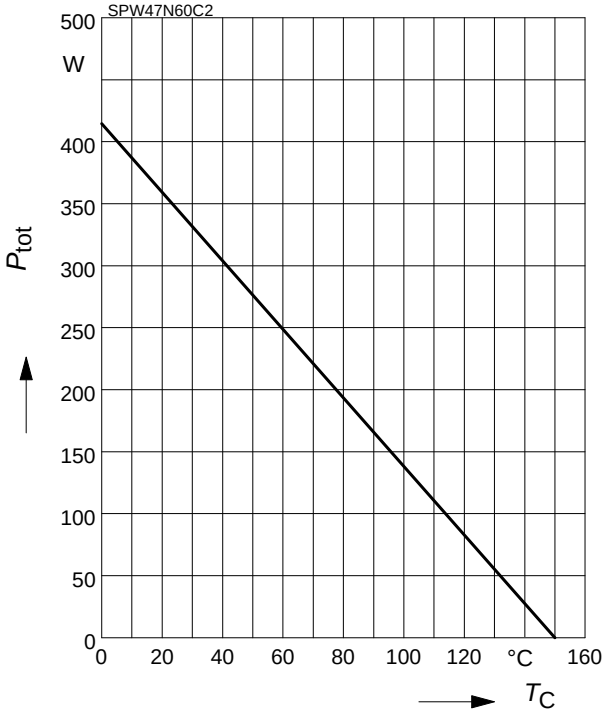
Typical Transient Thermal Characteristics

Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
Thermal resistance			Thermal capacitance		
R_{th1}	0.002694	K/W	C_{th1}	0.001219	Ws/K
R_{th2}	0.006036		C_{th2}	0.004011	
R_{th3}	0.00791		C_{th3}	0.006484	
R_{th4}	0.023		C_{th4}	0.008028	
R_{th5}	0.035		C_{th5}	0.05	
R_{th6}	0.018		C_{th6}	0.316	



1 Power dissipation

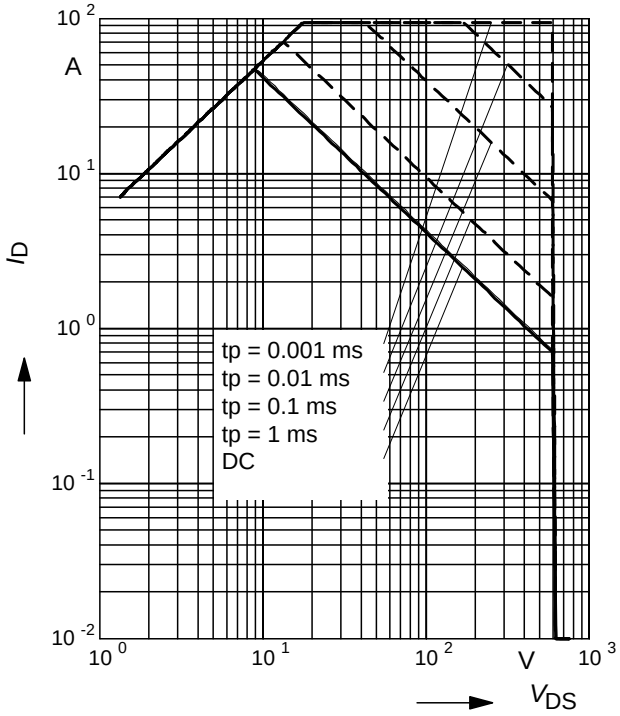
$P_{tot} = f(T_C)$



2 Safe operating area

$I_D = f(V_{DS})$

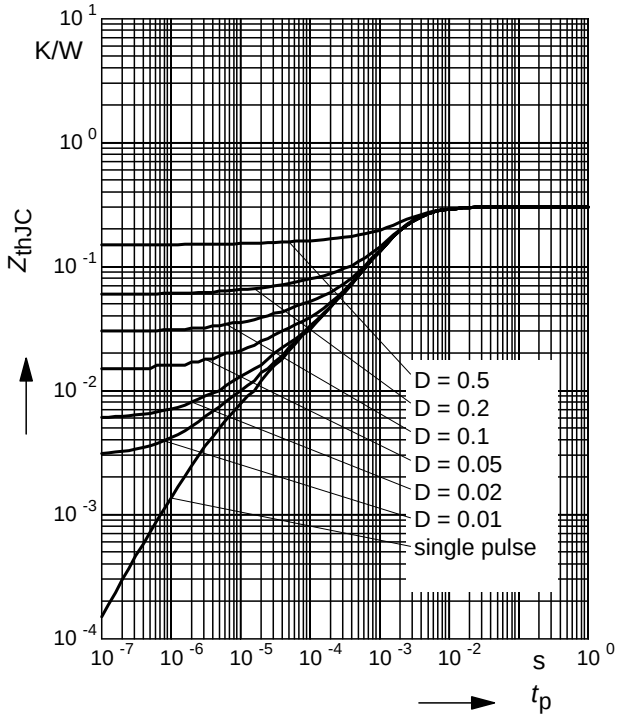
parameter : $D = 0$, T_C=25°C



3 Transient thermal impedance

$Z_{thJC} = f(t_p)$

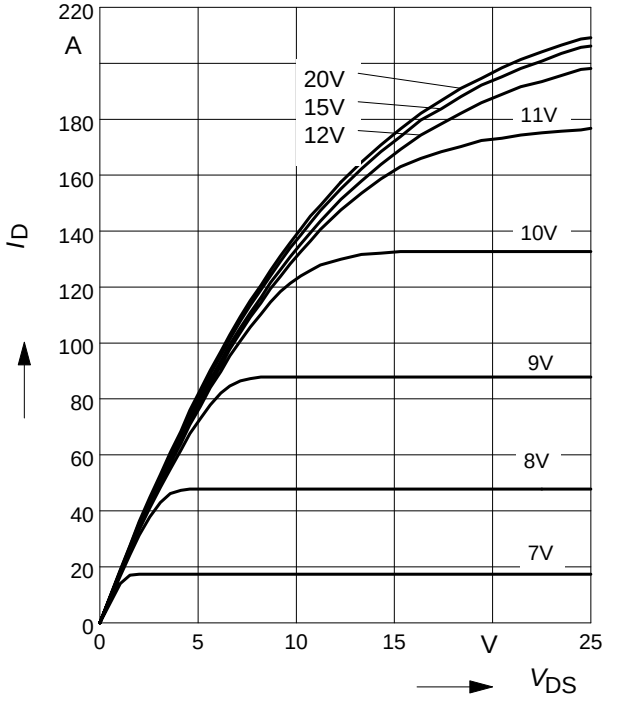
parameter: $D = t_p/T$



4 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=25°C

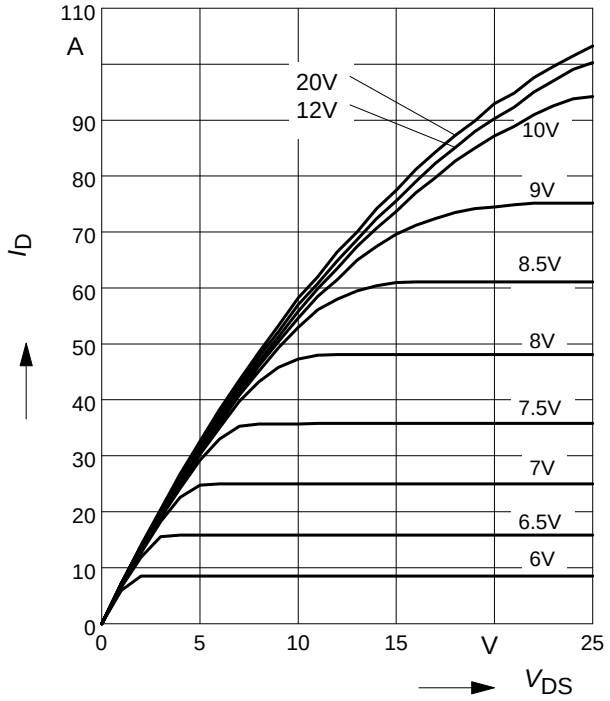
parameter: t_p = 10 µs, V_{GS}



5 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=150°C

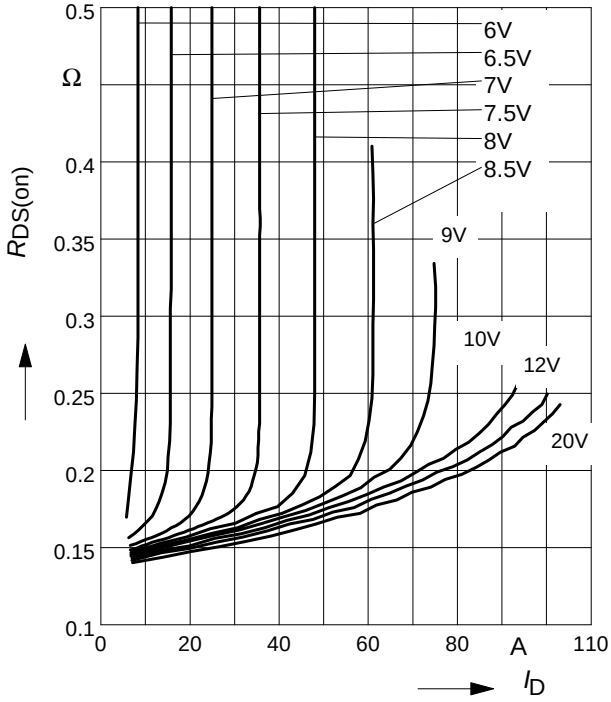
parameter: t_p = 10 µs, V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D)$

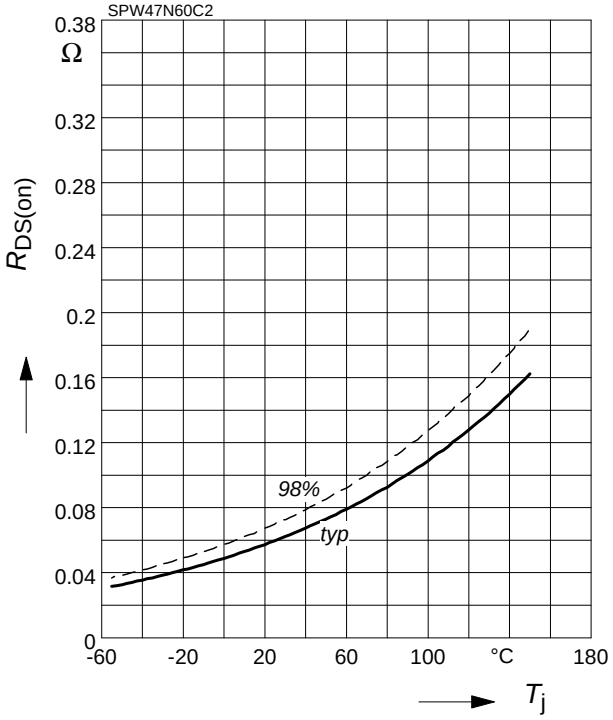
parameter: T_j=150°C, V_{GS}



7 Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$

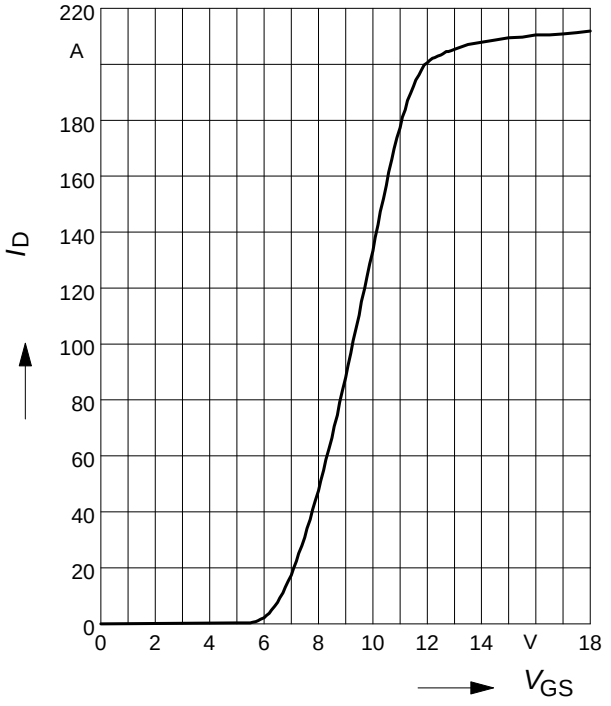
parameter : I_D = 30 A, V_{GS} = 10 V



8 Typ. transfer characteristics

$I_D= f(V_{GS})$; $V_{DS}\geq 2 \times I_D \times R_{DS(on)max}$

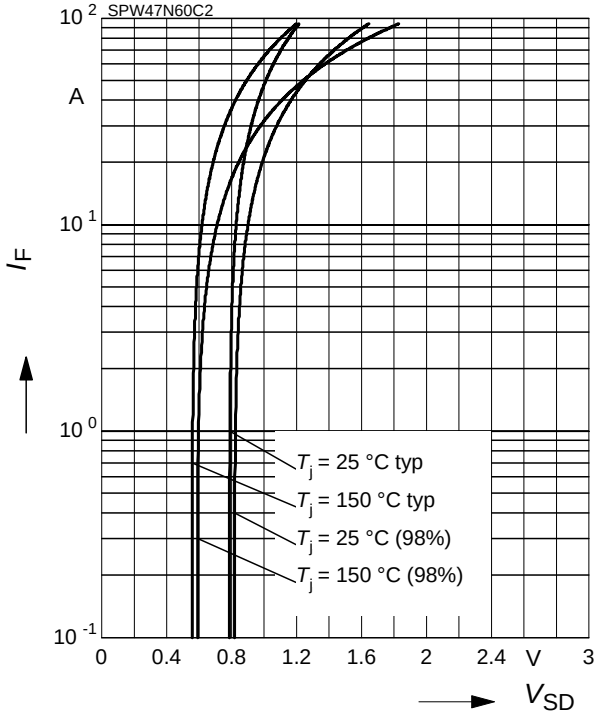
parameter: t_p = 10 µs



9 Forward characteristics of body diode

$I_F = f(V_{SD})$

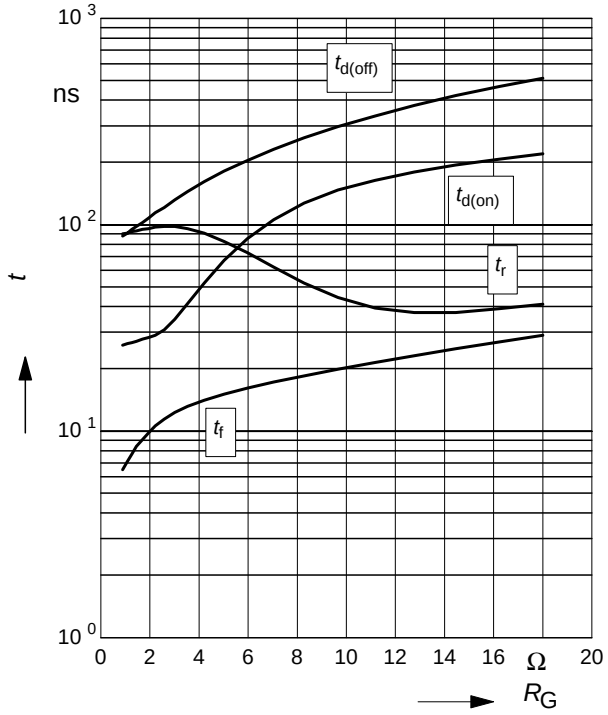
parameter: T_j , tp = 10 µs



10 Typ. switching time

$t = f(R_G)$, inductive load, T_j=125°C

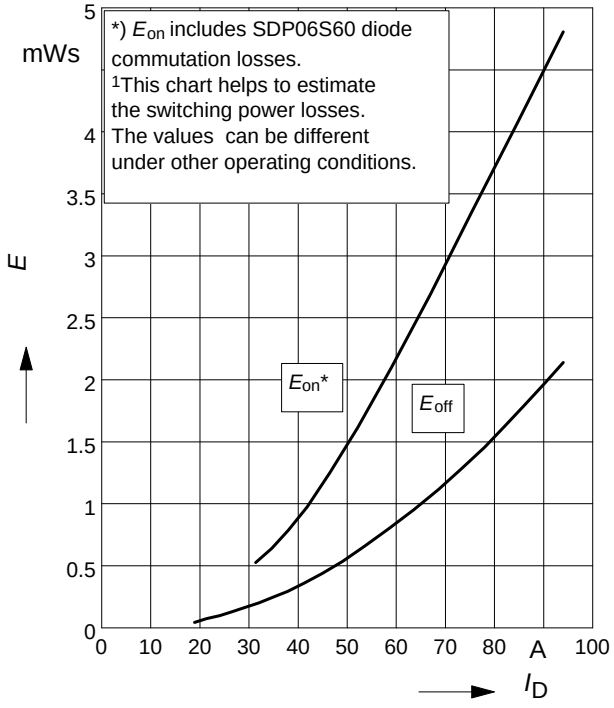
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=47 A



11 Typ. switching losses[1)]

$E = f(I_D)$, inductive load, T_j=125°C

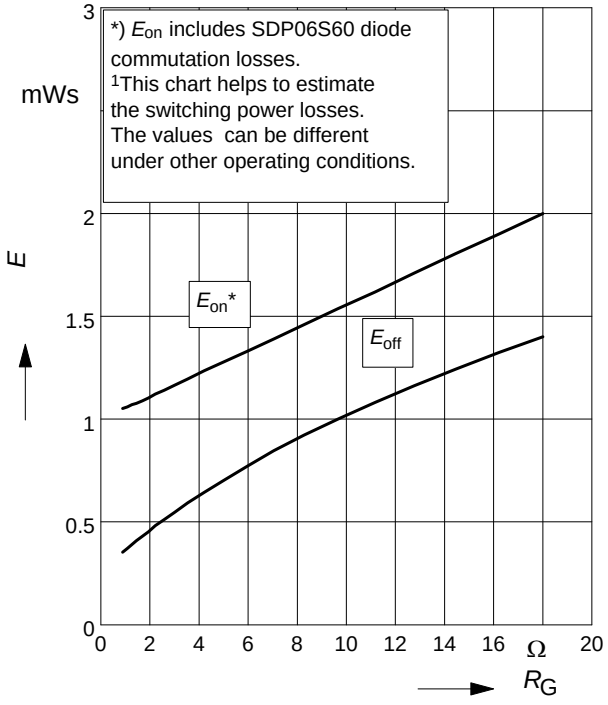
par.: V_{DS}=380V, V_{GS}=0/+13V, R_G=1.8Ω



12 Typ. switching losses[1)]

$E = f(R_G)$, inductive load, T_j=125°C

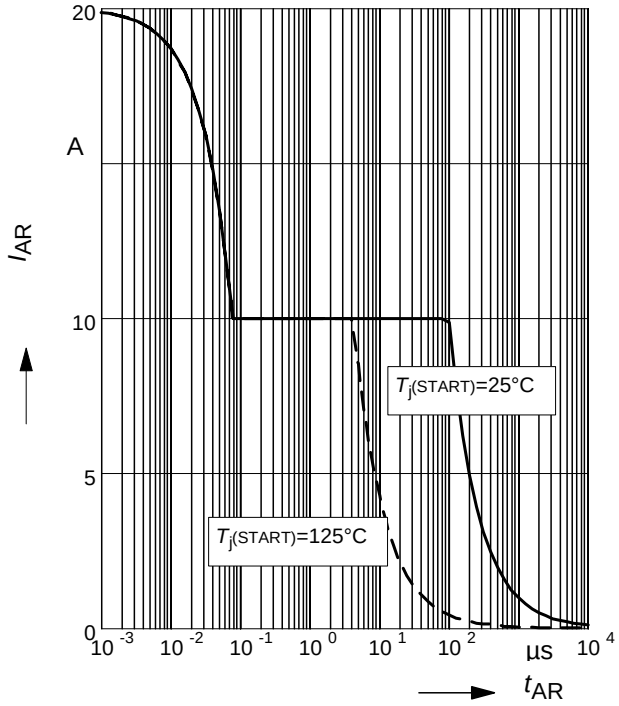
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=47 A



13 Avalanche SOA

$I_{AR} = f(t_{AR})$

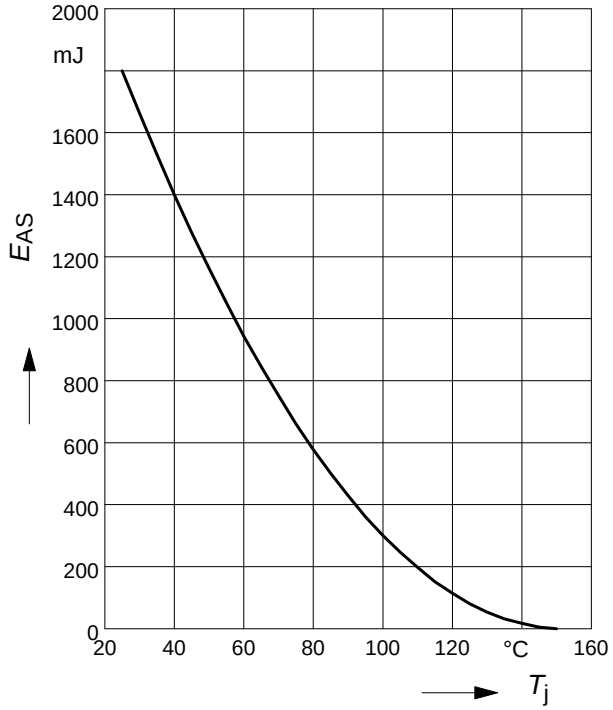
par.: $T_j \leq 150$ °C



14 Avalanche energy

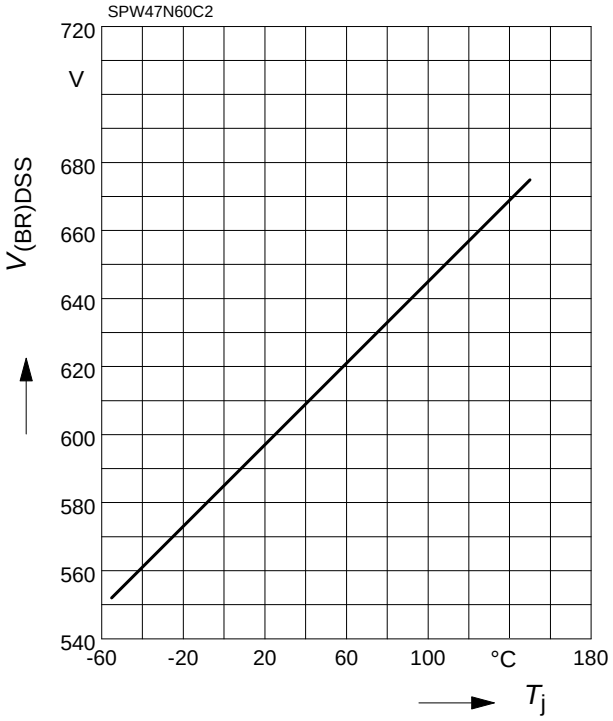
$E_{AS} = f(T_j)$

par.: I_D = 10 A, V_{DD} = 50 V



15 Drain-source breakdown voltage

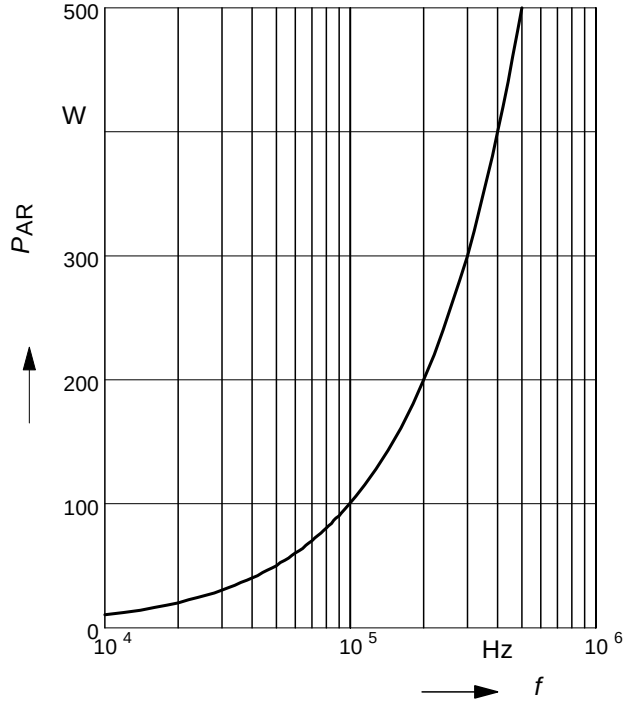
$V_{(BR)DSS} = f(T_j)$



16 Avalanche power losses

$P_{AR} = f(f)$

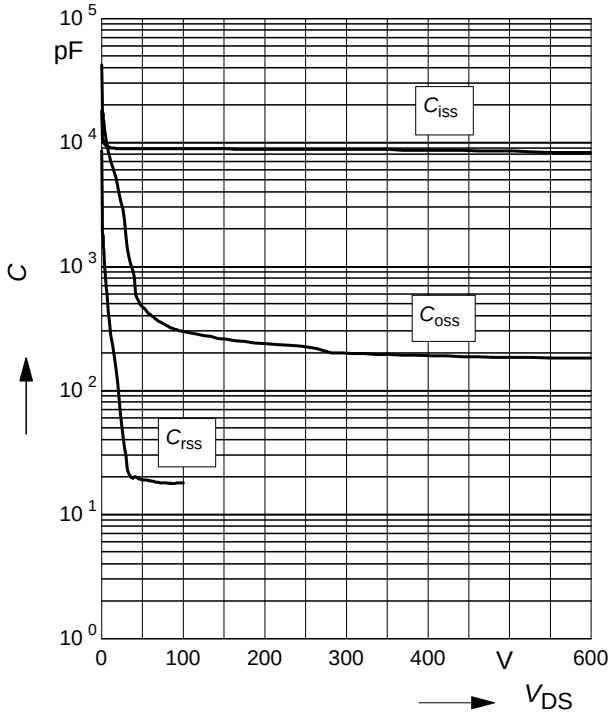
parameter: E_{AR}=1mJ



17 Typ. capacitances

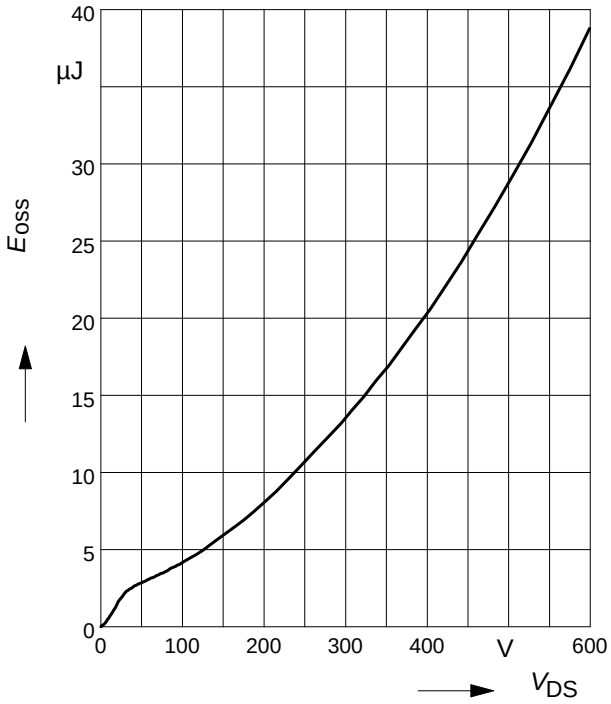
$C = f(V_{DS})$

parameter: V_{GS}=0V, f=1 MHz

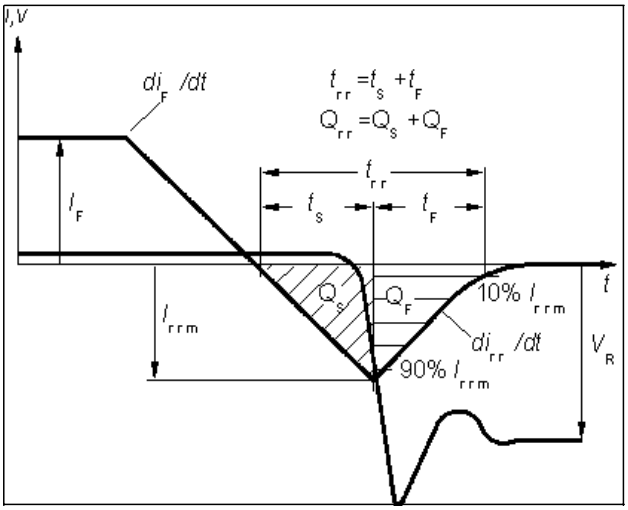


18 Typ. C_{oss} stored energy

$E_{oss}=f(V_{DS})$



Definition of diodes switching characteristics



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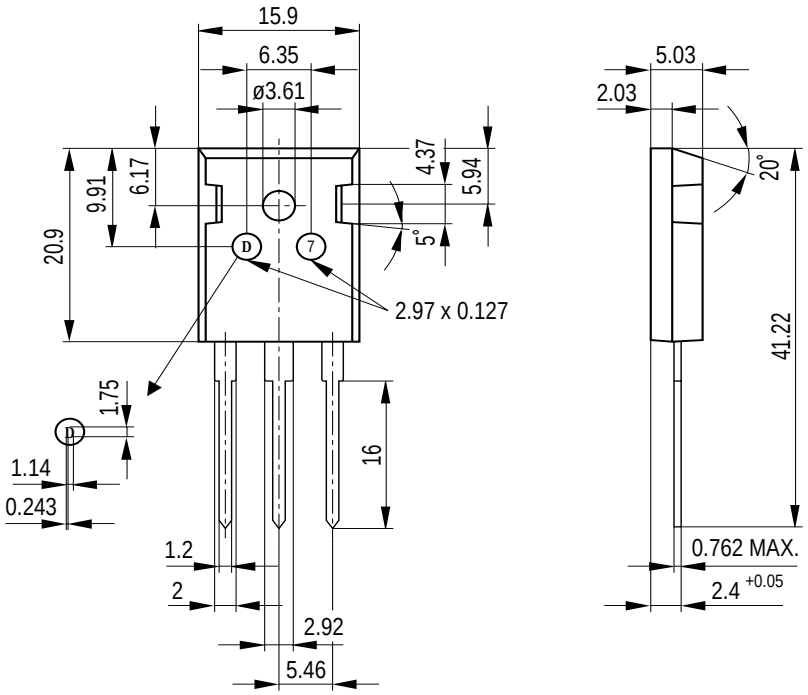

General tolerance unless otherwise specified: Leadframe parts: ±0.05
Package parts: ±0.12

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